# Two-scale impedance simulation for failure detection in PV modules

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#### Module scale: impedance measurement and fit



## top-down approach: equivalent circuit modeling



By using an RC circuit as the smallsignal model for each cell, and assuming a connection in series, plus a (cumulative) inductance arising from the wires, we obtain an equivalent circuit with the following estimated parameters:



#### bottom-up approach: cell-scale simulation

- At ZHAW-ICP: cell-scale results from fundamental material properties, for a prescribed cell geometry.
- 1D-2D coupled mathematical model for
  - (vertical) charge transport in semiconductor stack,
  - (lateral) charge transport in electrodes.
- Numerical simulation by the finite element method.





## Available simulation software at ZHAW-ICP

We have simulation software available for both steady-state (DC) and small-signal (AC) analyses, and for both small-area and large-area devices:

	steady state (DC)	small signal (AC)
small area (1D)	$\checkmark$	$\checkmark$
large area (1D-2D)	$\checkmark$	under development

Furthermore, the software products Setfos and Laoss by Fluxim AG can be used for these simulations.



laoss 2.1

Simulation software for design and optimization of large-area OLEDs, solar cells and modules

## cell-scale simulation results



electroluminescence (simulated in Laoss and measured):

(by M. Diethelm, now at Empa, Functional Polymers group)

## Summary of the proposed two-scale approach

Our proposed two-scale method joins the top-down and bottom-up approaches:



Cell-scale measurements may be carried out using hardware product Paios by Fluxim AG. V/UHF measurements at SUPSI.



characterization of solar cells and OLEDs

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characterization of solar cells and OLEDs

We are looking for industry partners to collaborate in a CTI R&D project.